

Notice of References Cited	Application/Control No. 10/798,178	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Cheung Lee	Art Unit 2812	Page 1 of 1

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	C	US-5,807,779	09-1998	Liaw, Jhon-Jhy	438/279
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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